New Mixed Metal Selenites and Tellurites Containing Pd²⁺ Ions in a Square Planar Geometry

Su-Yu Zhang,^{a, b} Chun-Li Hu,^a Jiang-Gao Mao*^{, a}

Supporting information

Table S1. State Energies (eV) of the L-CB and the H-VB of the title compounds.

Scheme S1. The coordination environments around Ba(II) in $BaPd(SeO_3)_2$ (a), Bi(III) in $Bi_2Pd(SeO_3)_4$ (b) and Pb() in $Pb_2Pd(SeO_3)_2Cl_2$ (c).

Figure S1. Simulated and experimental XRD powder patterns for $BaPd(SeO_3)_2$ (a), $Bi_2Pd(SeO_3)_4$ (b), $Pb_2Pd(SeO_3)_2Cl_2$ (c) and $Pb_2Pd(TeO_3)_2Cl_2$ (d).

Figure S2. IR Spectra of $BaPd(SeO_3)_2$ (a), $Bi_2Pd(SeO_3)_4$ (b), $Pb_2Pd(SeO_3)_2Cl_2$ (c), and $Pb_2Pd(TeO_3)_2Cl_2$ (d).

Figure S3. Absorption spectra for $BaPd(SeO_3)_2$ (a), $Bi_2Pd(SeO_3)_4$ (b), $Pb_2Pd(SeO_3)_2Cl_2$ (c) and $Pb_2Pd(TeO_3)_2Cl_2$ (d).

Figure S4. Optical diffuse reflectance spectra for $BaPd(SeO_3)_2$ (a), $Bi_2Pd(SeO_3)_4$ (b), $Pb_2Pd(SeO_3)_2Cl_2$ (c) and $Pb_2Pd(TeO_3)_2Cl_2$ (d).

Figure S5. The PXRD patterns of the thermal decomposition residuals for BaPd(SeO₃)₂.

Figure S6. The band structures of BaPd(SeO₃)₂, $Bi_2Pd(SeO_3)_4$ and $Pb_2Pd(QO_3)_2Cl_2$ (Q = Se, Te).

Figure S7. The total density of states and partial density of states of $BaPd(SeO_3)_2$, $Bi_2Pd(SeO_3)_4$ and $Pb_2Pd(QO_3)_2Cl_2$ (Q = Se, Te) (the Fermi level is set at 0 eV).

Cif files for the structures.

BaPd(SeO ₃) ₂	k-point	L-CB	H-VB
(-0.500 0.000 0.500)	L	1.333601	-0.28069
(-0.500 -0.500 0.500)	М	2.051396	-0.47514
(-0.500 0.000 0.000)	А	1.321754	-0.2795
(0.000 0.000 0.000)	G	2.005804	0
(0.000 -0.500 0.500)	Z	1.333602	-0.28069
(0.000 0.000 0.500)	Y	2.040714	-0.0876
Bi ₂ Pd(SeO ₃) ₄	k-point	L-CB	H-VB
(0.000 0.000 0.500)	Z	1.87506	-0.06531
(0.000 0.000 0.000)	G	1.732786	-0.00947
(0.000 0.500 0.000)	Y	1.901132	-0.0588
(-0.500 0.500 0.000)	А	1.859624	-0.07155
(-0.500 0.000 0.000)	В	1.746502	0
		1.730646	-0.00661
(-0.500 0.000 0.500)	D	1.911726	-0.07887
(-0.500 0.500 0.500)	Е	1.909796	-0.01988
(0.000 0.500 0.500)	С	1.911236	-0.00703
Pb ₂ Pd(SeO ₃) ₂ Cl ₂	k-point	L-CB	H-VB
(0.000 0.000 0.500)	Z	1.611028	-0.22459
(0.000 0.000 0.000)	G	1.435236	-0.27218

Table S1. State Energies (eV) of the L-CB and the H-VB of the title compounds.

(0.000 0.500 0.000)	Y	1.74822	-0.17649
(-0.500 0.500 0.000)	А	1.697095	-0.23647
(-0.500 0.000 0.000)	В	1.667216	0
(-0.500 0.000 0.500)	D	1.65292	-0.22256
(-0.500 0.500 0.500)	Е	1.724946	-0.13943
(0.000 0.500 0.500)	С	1.745808	-0.20726
Pb ₂ Pd(TeO ₃) ₂ Cl ₂	k-point	L-CB	H-VB
(0.000 0.000 0.500)	Z	1.692913	-0.2669
(0.000 0.000 0.000)	G	1.426912	-0.28505
(0.000 0.500 0.000)	Y	1.777802	-0.11053
(-0.500 0.500 0.000)	А	1.720093	-0.20291
(-0.500 0.000 0.000)	В	1.695195	0
(-0.500 0.000 0.500)	D	1.693771	-0.19609
(-0.500 0.500 0.500)	Е	1.751475	-0.15054
(0.000 0.500 0.500)	С	1.79618	-0.12339



Scheme S1. The coordination environments around Ba(II) in $BaPd(SeO_3)_2$ (a), Bi(III) in $Bi_2Pd(SeO_3)_4$ (b) and Pb() in $Pb_2Pd(SeO_3)_2Cl_2$ (c).







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Figure S2. IR Spectra of $BaPd(SeO_3)_2$ (a), $Bi_2Pd(SeO_3)_4$ (b), $Pb_2Pd(SeO_3)_2Cl_2$ (c), and $Pb_2Pd(TeO_3)_2Cl_2$ (d).





Figure S3. Absorption spectra for $BaPd(SeO_3)_2$ (a), $Bi_2Pd(SeO_3)_4$ (b), $Pb_2Pd(SeO_3)_2Cl_2$ (c) and $Pb_2Pd(TeO_3)_2Cl_2$ (d).



(a)





Figure S4. Optical diffuse reflectance spectra for $BaPd(SeO_3)_2$ (a), $Bi_2Pd(SeO_3)_4$ (b), $Pb_2Pd(SeO_3)_2Cl_2$ (c) and $Pb_2Pd(TeO_3)_2Cl_2$ (d).



Figure S5. The PXRD patterns of the thermal decomposition residuals for $BaPd(SeO_3)_2$.



Figure S6. The band structures of $BaPd(SeO_3)_2$, $Bi_2Pd(SeO_3)_4$ and $Pb_2Pd(QO_3)_2Cl_2$ (Q = Se, Te).



Figure S7. The total density of states and partial density of states of BaPd(SeO₃)₂, $Bi_2Pd(SeO_3)_4$ and $Pb_2Pd(QO_3)_2Cl_2$ (Q = Se, Te) (the Fermi level is set at 0 eV).

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Refinement of F^2^ against ALL reflections. The weighted R-factor wR and goodness of fit S are based on F^2^, conventional R-factors R are based on F, with F set to zero for negative F^2^. The threshold expression of $F^2^> 2 \text{sigma}(F^2^-)$ is used only for calculating R-factors(gt) etc. and is not relevant to the choice of reflections for refinement. R-factors based on F^2^ are statistically about twice as large as those based on F, and R-factors based on ALL data will be even larger.

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All esds (except the esd in the dihedral angle between two l.s. planes) are estimated using the full covariance matrix. The cell esds are taken into account individually in the estimation of esds in distances, angles and torsion angles; correlations between esds in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell esds is used for estimating esds involving l.s. planes.

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Higashi, T. (1995). Program for Absorption Correction. Rigaku Corporation, Tokyo, Japan.

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Se2 O1 Pd1 118.5(2) . 1 554 ?
Se2 O1 Bi1 105.27(16) . 3 556?
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Sel O2 Bil 136.06(19). 3 557?
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Se2 O4 Pd1 112.26(19) . 2_446 ?
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Attachment '- zsy-dalton-revised.CIF'

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_audit_creation_method SHELXL-97

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Higashi, T. (1995). Program for Al	osorption Correction.
Rigaku Corporation, Tokyo, Japan	
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_refine_special_details

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Refinement of F^2^ against ALL reflections. The weighted R-factor wR and goodness of fit S are based on F^2^, conventional R-factors R are based on F, with F set to zero for negative F^2^. The threshold expression of $F^2^> 2sigma(F^2^-)$ is used only for calculating R-factors(gt) etc. and is not relevant to the choice of reflections for refinement. R-factors based on F^2^ are statistically about twice as large as those based on F, and R-factors based on ALL data will be even larger.

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refine ls matrix type
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_refine_ls_weighting details
'calc w=1/[s^2(Fo^2)+(0.0250P)<sup>2</sup>+0.0000P] where P=(Fo<sup>2</sup>+2Fc<sup>2</sup>)/3'
atom sites solution primary
                                    direct
atom sites solution secondary
                                   difmap
atom sites solution hydrogens
                                    constr
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loop_

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loop_

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O3 0.023(2) 0.0052(17) 0.010(2) 0.0006(14) 0.0035(17) -0.0038(15)

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;

All esds (except the esd in the dihedral angle between two l.s. planes) are estimated using the full covariance matrix. The cell esds are taken into account individually in the estimation of esds in distances, angles and torsion angles; correlations between esds in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell esds is used for estimating esds involving l.s. planes.

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loop_

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